

MOSFETs Silicon N-Channel MOS

SSM3H137TU

1. Applications

· Relay Drivers

2. Features

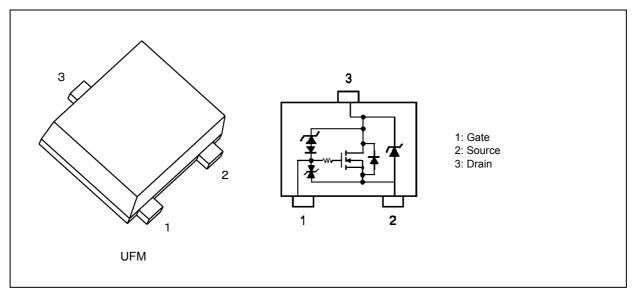
- (1) AEC-Q101 (Rev. D) qualified. (Note 1)
- (2) 4.0-V gate drive voltage.
- (3) Low drain-source on-resistance
 - : $R_{DS(ON)}$ = 295 m Ω (max) (@ V_{GS} = 4.0 V, I_{D} = 0.5 A)

 $R_{DS(ON)} = 280 \text{ m}\Omega \text{ (max) (@V_{GS} = 4.5 V, I_D = 1.0 A)}$

 $R_{DS(ON)}$ = 240 m Ω (max) (@ V_{GS} = 10 V, I_{D} = 1.0 A)

Note 1: For detail information, Please contact to our sales.

3. Packaging and Pin Assignment





4. Absolute Maximum Ratings (Note) (Unless otherwise specified, Ta = 25 °C)

Characteristics			Symbol	Rating	Unit
Drain-source voltage			V _{DSS}	34	V
Gate-source voltage			V_{GSS}	±20	
Drain current (DC)		(Note 1)	I _D	2	Α
Drain current (pulsed)		(Note 1), (Note 2)	I _{DP}	6	
Power dissipation		(Note 3)	P_{D}	800	mW
Power dissipation	(t = 1 s)	(Note 3)		1000	
Channel temperature			T _{ch}	150	°C
Single-pulse avalanche energy		(Note 4)	E _{AS}	3.5	mJ
Avalanche current			I _{AR}	2.0	Α
Storage temperature			T _{stg}	-55 to 150	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

- Note 1: Ensure that the channel temperature does not exceed 150 °C.
- Note 2: Pulse width (PW) \leq 10 μ s, duty \leq 1%
- Note 3: Device mounted on an FR4 board. (25.4 mm × 25.4 mm × 1.6 mm ,Cu pad: 645 mm²)
- Note 4: V_{DD} = 25 V, Starting T_{ch} = 25 °C, L = 0.5 mH

Note: The MOSFETs in this device are sensitive to electrostatic discharge. When handling this device, the worktables, operators, soldering irons and other objects should be protected against anti-static discharge.

Note: The channel-to-ambient thermal resistance, $R_{th(ch-a)}$, and the drain power dissipation, P_D , vary according to the board material, board area, board thickness and pad area. When using this device, be sure to take heat dissipation fully into account.



5. Electrical Characteristics

5.1. Static Characteristics (Unless otherwise specified, T_a = 25 °C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Drain-source breakdown voltage		V _{(BR)DSS}	$I_D = 1 \text{ mA}, V_{GS} = 0 \text{ V}$	34	_	37	V
Drain cut-off current		I _{DSS}	V _{DS} = 30.4 V, V _{GS} = 0V			10	μА
Gate leakage current		I _{GSS}	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0 \text{ V}$			±10	
Gate threshold voltage	(Note 1)	V_{th}	V _{DS} = 10 V, I _D = 1 mA	0.7		1.7	V
Drain-source on-resistance	(Note 2)	R _{DS(ON)}	$V_{GS} = 4.0 \text{ V}, I_D = 0.5 \text{ A}$		230	295	mΩ
			V _{GS} = 4.5 V, I _D = 1.0 A	_	220	280	
			V _{GS} = 10 V, I _D = 1.0 A	_	200	240	
Forward transfer admittance	(Note 2)	Y _{fs}	$V_{DS} = 10 \text{ V}, I_{D} = 0.5 \text{ A}$	_	2.2		S

Note 1: Let V_{th} be the voltage applied between gate and source that causes the drain current (I_D) to below (1 mA for this device). Then, for normal switching operation, $V_{GS(ON)}$ must be higher than V_{th} , and $V_{GS(OFF)}$ must be lower than V_{th} . This relationship can be expressed as: $V_{GS(OFF)} < V_{th} < V_{GS(ON)}$.

Take this into consideration when using the device.

Note 2: Pulse measurement.

5.2. Dynamic Characteristics (Unless otherwise specified, T_a = 25 °C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Input capacitance	C _{iss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V},$	_	119	_	pF
Reverse transfer capacitance	C _{rss}	f = 1 MHz	_	8		
Output capacitance	Coss		_	40		
Switching time (turn-on time)	t _{on}	$V_{DD} = 20 \text{ V}, I_D = 0.5 \text{ A},$ $V_{GS} = 0 \text{ to } 4.5 \text{ V}, R_G = 10 \Omega$	_	320		ns
Switching time (turn-off time)	t _{off}	Duty \leq 1%, V_{IN} : t_r , t_f < 5 ns, Common source, See Chapter 5.3.	_	800		

5.3. Switching Time Test Circuit

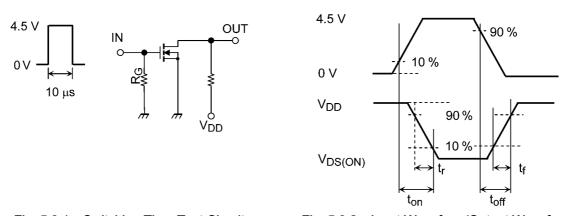


Fig. 5.3.1 Switching Time Test Circuit

Fig. 5.3.2 Input Waveform/Output Waveform

5.4. Gate Charge Characteristics (Unless otherwise specified, Ta = 25 °C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Total gate charge (gate-source plus gate-drain)	Qg	V_{DD} = 20 V, I_{D} = 1.0 A,	_	3.0	_	nC
Gate-source charge 1	Q _{gs1}	V _{GS} = 10 V	_	0.8		
Gate-drain charge	Q_{gd}			0.4		

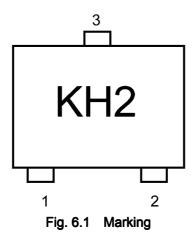


5.5. Source-Drain Characteristics (Unless otherwise specified, T_a = 25 °C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Diode forward voltage (Note	1) V _{DSF}	$I_D = -2.0 \text{ A}, V_{GS} = 0 \text{ V}$		-0.82	-1.2	V

Note 1: Pulse measurement.

6. Marking



7. Characteristics Curves (Note)

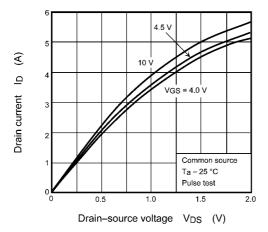


Fig. 7.1 $I_D - V_{DS}$

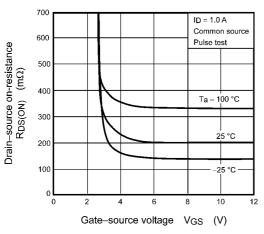


Fig. 7.3 R_{DS(ON)} - V_{GS}

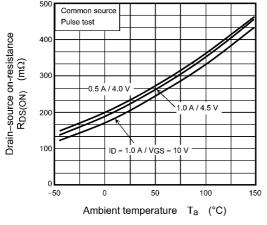


Fig. 7.5 R_{DS(ON)} - T_a

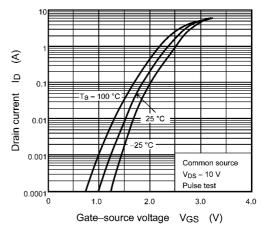


Fig. 7.2 I_D - V_{GS}

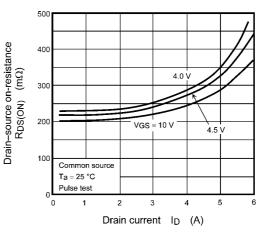


Fig. 7.4 R_{DS(ON)} - I_D

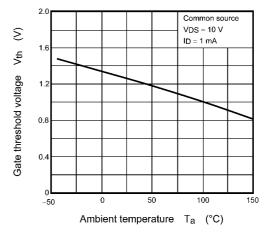


Fig. 7.6 V_{th} - T_a

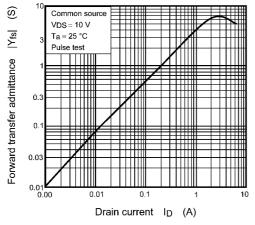
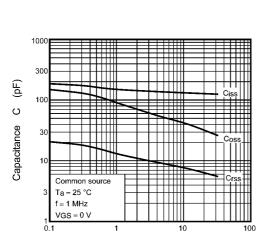


Fig. 7.7 |Y_{fs}| - I_D



Drain–source voltage V_{DS} (V) Fig. 7.9 C - V_{DS}

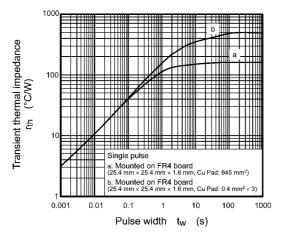


Fig. 7.11 r_{th} - t_w (MOSFET)

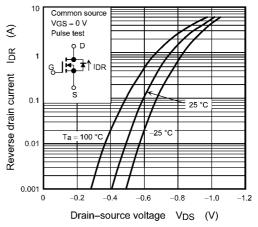


Fig. 7.8 I_{DR} - V_{DS}

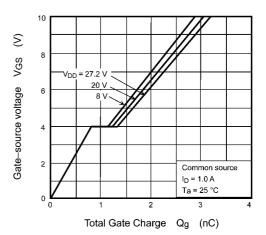


Fig. 7.10 Dynamic Input Characteristics

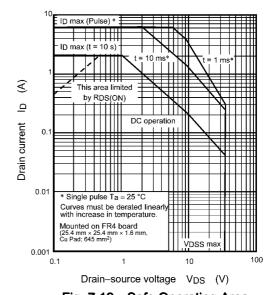
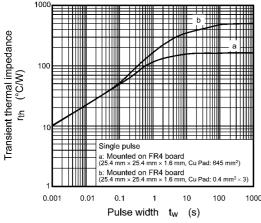


Fig. 7.12 Safe Operating Area



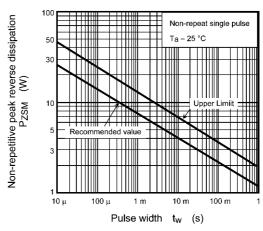


Fig. 7.13 rth - tw (Zener)

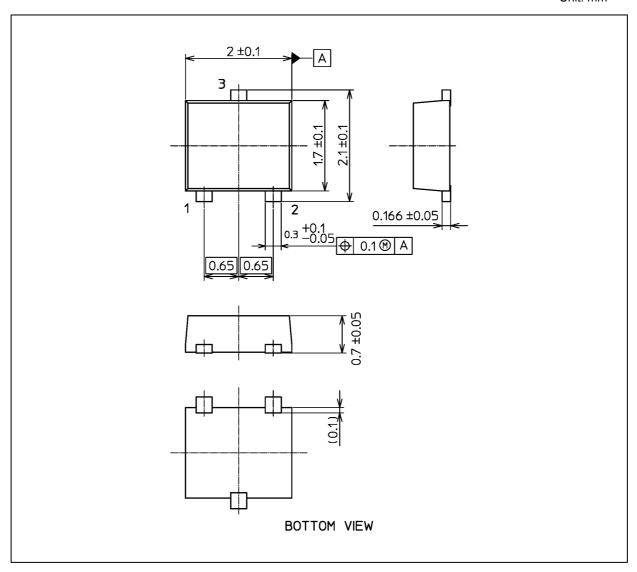
Fig. 7.14 P_{ZSM} - t

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.



Package Dimensions

Unit: mm



Weight: 6.6 mg (typ.)

	Package Name(s)	
Nickname: UFM		



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